

## UNITED STATES PATENT AND TRADEMARK OFFICE

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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/007,631	11/09/2001	Daniel S. Pickard	S01-079	1649
75	590 04/01/2003			
MAREK ALBOSZTA LUMEN INTELLECTUAL PROPERTY SERVICES SUITE 110 45 CABOT AVENUE SANTA CLARA, CA 95051			EXAMINER	
			NGUYEN, JOSEPH H	
			ART UNIT	PAPER NUMBER
C.L. TIT OBIN	, ,,,,,,		2815	

Please find below and/or attached an Office communication concerning this application or proceeding.

<del>• '</del> ¿							
		Application No.	Applicant(s)				
	Office Astion Occurrence	10/007,631	PICKARD ET AL.				
Office Action Summary		Examiner	Art Unit				
		Joseph Nguyen	2815				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.  - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.  - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).  - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).  Status							
1)	Responsive to communication(s) filed on	<u> </u>					
2a)[☐	This action is <b>FINAL</b> . 2b)⊠ Thi	s action is non-final.					
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
·	ion of Claims						
	Claim(s) 1-27 is/are pending in the application.						
	4a) Of the above claim(s) is/are withdrawn from consideration.						
·	Claim(s) is/are allowed.						
	Claim(s) 1-27 is/are rejected.						
	7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or election requirement.						
	on Papers	election requirement.					
9) 🗌 .	The specification is objected to by the Examiner						
10)⊠ The drawing(s) filed on <u>09 November 2001</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
11) The proposed drawing correction filed on is: a) approved b) disapproved by the Examiner.							
If approved, corrected drawings are required in reply to this Office action.							
12) The oath or declaration is objected to by the Examiner.							
Priority under 35 U.S.C. §§ 119 and 120							
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).							
a) All b) Some * c) None of:							
	1. Certified copies of the priority documents have been received.						
	2. Certified copies of the priority documents have been received in Application No						
* S	<ul> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>						
14) 🗌 A	14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).						
a) ☐ The translation of the foreign language provisional application has been received.  15) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.							
Attachment	t(s)						
2) 🔲 Notice	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449) Paper No(s) <u>3</u> .		(PTO-413) Paper No(s) Patent Application (PTO-152)				

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## **DETAILED ACTION**

## Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-27 are rejected under 35 U.S.C. 102(b) as being anticipated by Fox et al.

Regarding claim 1, Fox et al discloses on figures 1 and 2 a semiconductor source of emission comprising a target 23 comprising a wide band gap semiconductor 24, said target having a target thickness between an illumination surface 26 and an emission surface 28; a means 20 for producing and directing a beam 22 of seed electrons at said illumination surface; a means 50 for controlling an energy of said seed electron s such that said seed electrons generate electron hole pairs in said target and a fraction of said electron hole pairs supply said emission electrons; and wherein said target thickness and the energy of said seed electrons are optimized such that said emission electrons are substantially thermalized at said emission surface.

Regarding claims 2-22, Fox et al discloses on figures 1 and 2 all the structures set forth in the claimed invention.

Regarding claim 23, Fox et al discloses on figures 1 and 2 a method for obtaining emission electrons from a target 23 comprising a wide bandgap semiconductor 24, said method comprising the following steps: defining a target thickness between an

are substantially thermalized at said emission surface.

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illumination surface 26 and an emission surface 28 of said target; generating a beam 22 of seed electrons; directing said beam of seed electrons at said illumination surface; controlling an energy of said seed electrons such that said seed electrons generate electron hole pairs supply said emission electrons; and wherein said target thickness and said energy of said seed electrons are optimized such that said emission electrons

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Regarding claims 24-27, Fox et al discloses on figures 1 and 2 all steps of the method set forth in claims 24-27.

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

US Patent 5684360 to Baum et al discloses an electron source.

US Patent US 6091186 to Cat et al discloses a photocathode.

## Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Joseph Nguyen whose telephone number is (703) 308-1269. The examiner can normally be reached on Monday-Friday, 7:30 am- 4:30 pm

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie Lee can be reached on (703) 308-1690. The fax phone numbers for the organization where this application or proceeding is assigned is (703) 308-7382 for regular communications.

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Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

JN March 21, 2003

> EDDIE LEE SUPERVISORY PATENT EXAMINER

**TECHNOLOGY CENTER 2800**